

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/668,255	HUNT ET AL.	
Examiner		Art Unit		Page 1 of 1
Lynne Edmondson		1725		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0082258	04-2005	Kim, Jaeyeon	216/083
*	B	US-5,879,524	03-1999	Hurwitt et al.	204/298.12
*	C	US-2005/0011749	01-2005	Kachalov et al.	204/192.12
*	D	US-2004/0020769	02-2004	Ivannov et al.	204/298.12
*	E	US-2004/0079634	04-2004	Wickersham et al.	204/298.12
*	F	US-6,708,870	03-2004	Koenigsmann et al.	228/210
*	G	US-6,176,986	01-2001	Watanabe et al.	204/298.13
*	H	US-2002/0100680	08-2002	Yamamoto et al.	204/192.12
*	I	US-2005/0263570	12-2005	Koenigsmann et al.	228/245
*	J	US-2005/0284746	12-2005	Ivanov, Eugene Y.	204/192.12
*	K	US-5,676,803	10-1997	Demaray et al.	204/192.12
*	L	US-5,230,459	07-1993	Mueller et al.	228/164
*	M	US-6,071,389	06-2000	Zhang, Hao	204/298.12

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 02043362 A	02-1990	Japan	OGATA et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.